

COATING THICKNESS GAUGE



Standard Configuration

Name	Quantity		
ACT280			
Probe			
Standard test plate	5		
Substrate			
Carrying Case	1		
Operation Manual	1		

Optional Accessories

Designation	Model		
Probes for other applications	F400, F1, F10, N1, CN02		

Technical Specifications

Measuring range				
Probes available				
Tolerance	Refer to the table below			
Minimum resolution:				
Measuring condition				
Operation language	English			
Standards	DIN, ISO, ASTM,BS			
Calibration	Zero and foil calibration			
Statistics	Number of measurements, mean, standard deviation maximum and minimum of 3000 readings			
Data memory	495 readings			
Humidity:	20% ~ 90%RH			
Environment of application:	0-40°C (No strong magnetic field)			
power supply	2×1.5V AA			
Dimensions	1250mm × 67 mm × 31 mm			
Weight	400g			



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Optional probes and technical specification

Probe model		F400		F1	F1/90°	F5	F10	
Operating principle		Magnetic induction						
Measuring range (μm)		0 ~ 400		0 ~ 1250		0 ~ 5000	0 ~ 10000	
Low range resolution(μm)		0.1		0.1		1	10	
Annua	One-point calibration (μm)	± (3%H+1)				± (3%H+5)	± (3%H+10)	
Accuracy	Two-point calibration (μm)	± ((1 ~ 3)%	6H+0.7)	± ((1 ~ 3)%H+1)		± ((1 ~ 3)%H+5)	± ((1 ~ 3)%H+10)	
Measuring conditions	Min curvature radius (mm)	Convex		1.5	Flatten	5	10	
	Diameter of the min area (mm)	Ф3		Ф7	Φ7	Ф20	Ф40	
	Critical thickness of substrate (mm)	0.2		0.5	0.5	Ť	2	

Probe model		N400		N1	N1/90°	CN02	N10	
Operating principle		Eddy current						
Measuring range (μm)		0 ~ 400		0 ~ 1250		10 ~ 200	0 ~ 10000	
Low range resolution(µm)		0.1		0.1		i	10	
Accuracy	One-point calibration (μm)	± (3%H+0.7)		± (3%H+1.5)		± (3%H+1)	± (3%H+25)	
	Two-point calibration (μm)	± [(1 ~ 3)%H+0.7]		± [(1 ~ 3)%H+1.5]			± [(1 ~ 3)%H+25]	
Measuring conditions	Min curvature radius (mm)	Convex	1.5	3	Flatten	Only flatten	25	
	Diameter of the min area (mm)	Ф4		Φ5	Ф5	Ф7	Ф50	

Application of two measuring method:

Magnetism method (F-probe)

The probe and the magnetic metal substrate will form a closed magnetic circuit when probe contacting with the coating. The magnetic resistance of closed magnetic circuit varies due to the existing of non-magnetic coating. The thickness of the coating can be measured through the variation of magnetic resistance.

Eddy current method (N-probe)

The high frequency alternating current generates an electromagnetic field in probe coil eddy current will be formed on metal substrate when the probe contacting with coating and the eddy current has an effect of feedback on the coil in probe. The thickness of the coating can be calculated through measuring the effect of feedback.



